

Search Notes



Application/Control No.

10/606,160

Examiner

CHUONG T. HO

Applicant(s)/Patent under Reexamination

WAN ET AL.

Art Unit

2616

SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|----------|----------|
| 370 | 352 | 05/23/07 | CH |
| 370 | 432 | | |
| 370 | 390 | | |
| 709 | 238 | | |
| 709 | 204 | | |
| 709 | 245 | | |
| 370 | 328 | | |
| 725 | 148 | | |
| 348 | 384.1 | | |
| 370 | 901 | | |
| 370 | 902 | | |
| 725 | 118 | | |
| 725 | 109 | | |
| 725 | 129 | | |
| 709 | 203 | | |

INTERFERENCE SEARCHED

| Class | Subclass | Date | Examiner |
|-------|----------|------|----------|
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)

| | DATE | EXMR |
|-------------------------------------|----------|------|
| WEST (Text search, class search) | 05/23/07 | CH |
| EAST | | |
| STN | | |
| IEEE | | |
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